

**Search Notes**

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Charles Kim

Applicant(s)/Patent under  
Reexamination

BASSO ET AL.

Art Unit

2623

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

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Interference Search Report		7/25/2005	CK

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
382/103,154,190,203,254,274,291; 348/14.01,14.08—text search (see search history report)	7/25/2005	CK
IEEE text search	7/25/2005	CK